


<b>Search Notes</b>  	<b>Application/Control No.</b>  09845596	<b>Applicant(s)/Patent Under Reexamination</b>  MILLER ET AL.
	<b>Examiner</b>  SARGON N NANO	<b>Art Unit</b>  2157

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted and searched the invention with Primary Meky	3/21/2008	SN
EIC search (see attached search report)	3/24/2008	SN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner